



# TF2181M

## High-Side and Low-Side Gate Driver

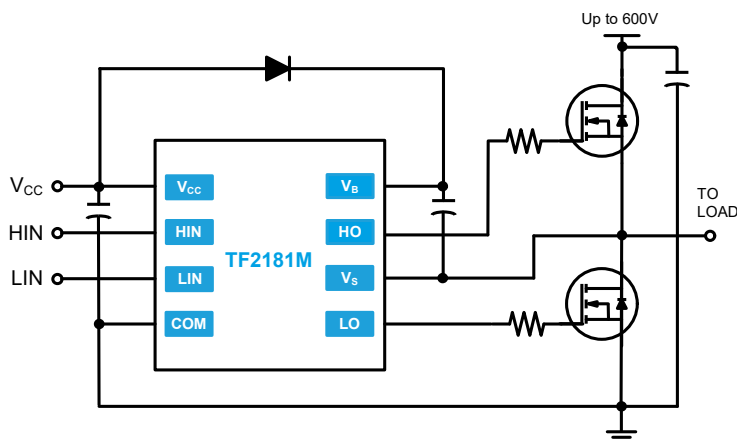
### Features

- Floating high-side driver in bootstrap operation to 600V
- Drives two N-channel MOSFETs or IGBTs in a half bridge configuration
- 1.9A source / 2.3A sink output current capability
- Outputs tolerant to negative transients
- Wide low side gate driver supply voltage: 10V to 20V
- Logic input (HIN and LIN) 3.3V capability
- Schmitt triggered logic inputs with internal pull down
- Undervoltage lockout for high and low side drivers
- Extended temperature range: -40°C to +125°C

### Applications

- DC-DC Converters
- AC-DC Inverters
- Motor Controls
- Class D Power Amplifiers

### Typical Application



### Description

The TF2181M is a high voltage, high speed gate driver capable of driving N-channel MOSFETs and IGBTs in a half bridge configuration. TF Semiconductor's high voltage process enables the TF2181M's high side to switch to 600V in a bootstrap operation.

The TF2181M logic inputs are compatible with standard TTL and CMOS levels (down to 3.3V) to interface easily with controlling devices. The driver outputs feature high pulse current buffers designed for minimum driver cross conduction.

The TF2181M is offered in PDIP-8 and SOIC-8(N) packages and operate over an extended -40°C to +125°C temperature range.



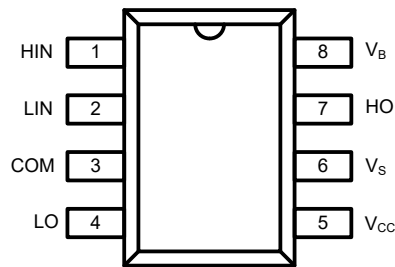
SOIC-8(N)

### Ordering Information

| PART NUMBER | PACKAGE   | PACK / Qty | Year | Year | Week | Week   |
|-------------|-----------|------------|------|------|------|--------|
|             |           |            | Year | Year | Week | Week   |
| TF2181M-3AS | PDIP-8    | Tube / 50  | TF   | YY   | WW   | Lot ID |
| TF2181M-TAU | SOIC-8(N) | Tube / 100 | TF   | YY   | WW   | Lot ID |
| TF2181M-TAH | SOIC-8(N) | T&R / 2500 | TF   | YY   | WW   | Lot ID |



## Pin Diagrams



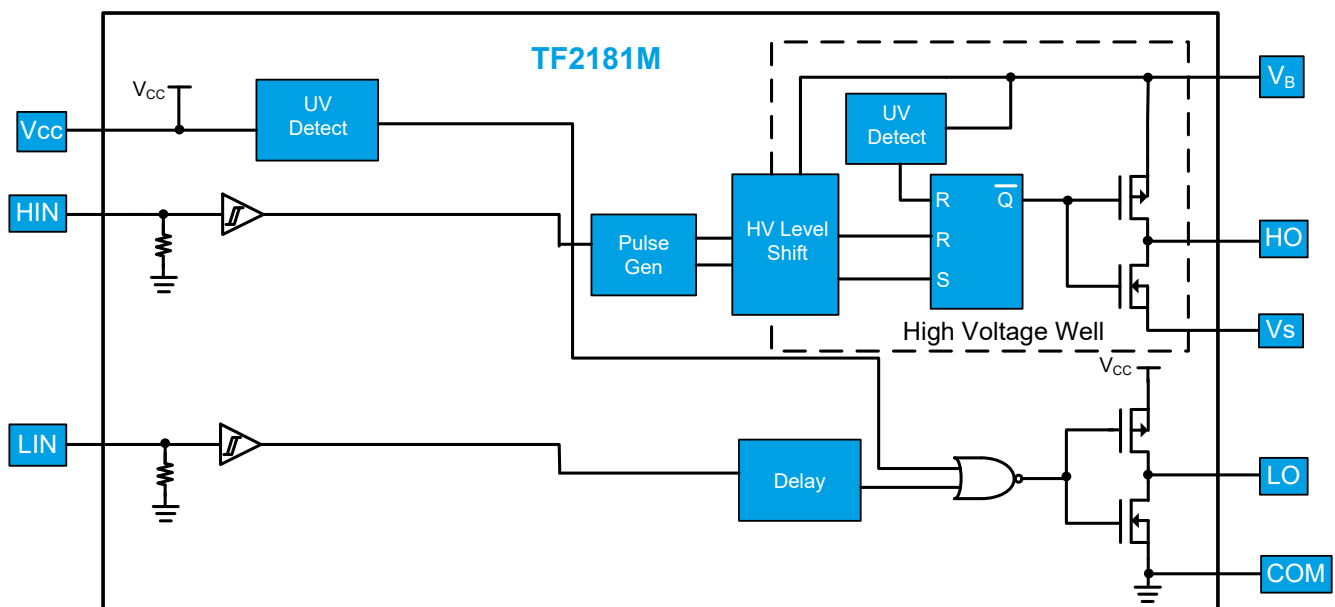
Top View: SOIC-8

TF2181M

## Pin Descriptions

| PIN NAME        | PIN NUMBER | PIN DESCRIPTION   |
|-----------------|------------|---|
| HIN             | 1          | Logic input for high-side gate driver output, in phase with HO. |
| LIN             | 2          | Logic input for low-side gate driver output, in phase with LO.  |
| COM             | 3          | Low-side and logic return                                       |
| LO              | 4          | Low-side gate drive output                                      |
| V <sub>CC</sub> | 5          | Low-side and logic fixed supply                                 |
| V <sub>S</sub>  | 6          | High-side floating supply return                                |
| HO              | 7          | High-side gate drive output                                     |
| V <sub>B</sub>  | 8          | High-side floating supply                                       |

## Functional Block Diagram





## Absolute Maximum Ratings (NOTE1)

$V_B$  - High side floating supply voltage.....-0.3V to +624V  
 $V_S$  - High side floating supply offset voltage... $V_B$ -24V to  $V_B$ +0.3V  
 $V_{HO}$  - High side floating output voltage..... $V_S$ -0.3V to  $V_B$ +0.3V  
 $dV_S/dt$  - Offset supply voltage transient.....50 V/ns

$V_{CC}$  - Low-side fixed supply voltage.....-0.3V to +24V  
 $V_{LO}$  - Low-side output voltage.....-0.3V to  $V_{CC}$ +0.3V  
 $V_{IN}$  - Logic input voltage (HIN and LIN).....-0.3V to  $V_{CC}$ +0.3V

**NOTE1** Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

$P_D$  - Package power dissipation at  $T_A \leq 25^\circ\text{C}$   
 SOIC-8.....0.625W

SOIC-8(N) Thermal Resistance (**NOTE2**)  
 $\theta_{JA}$ .....200  $^\circ\text{C}/\text{W}$

$T_J$  - Junction operating temperature.....+150  $^\circ\text{C}$   
 $T_L$  - Lead Temperature (soldering, 10 seconds).....+300  $^\circ\text{C}$   
 $T_{stg}$  - Storage temperature .....-55 to 150  $^\circ\text{C}$

**NOTE2** Thermal resistance and power dissipation ratings are measured under board mounted and still air conditions.

## Recommended Operating Conditions

| Symbol   | Parameter                                  | MIN          | MAX        | Unit             |
|----------|--|--------------|------------|------------------|
| $V_B$    | High side floating supply absolute voltage | $V_S + 10$   | $V_S + 20$ | V                |
| $V_S$    | High side floating supply offset voltage   | <b>NOTE3</b> | 600        | V                |
| $V_{HO}$ | High side floating output voltage          | $V_S$        | $V_B$      | V                |
| $V_{CC}$ | Low side fixed supply voltage              | 10           | 20         | V                |
| $V_{LO}$ | Low side output voltage                    | 0            | $V_{CC}$   | V                |
| $V_{IN}$ | Logic input voltage (HIN and LIN)          | 0            | 5          | V                |
| $T_A$    | Ambient temperature                        | -40          | 125        | $^\circ\text{C}$ |

**NOTE3** Logic operational for  $V_S$  of -5V to +600V.



## DC Electrical Characteristics (NOTE4)

$V_{BIAS} (V_{CC}, V_{BS}) = 15V, T_A = 25^\circ C$ , unless otherwise specified.

| Symbol      | Parameter  | Conditions                    | MIN | TYP | MAX | Unit    |
|-------------|--|-------------------------------|-----|-----|-----|---------|
| $V_{IH}$    | Logic "1" input voltage                                | $V_{CC} = 10V$ to $20V$       | 2.5 |     |     | V       |
| $V_{IL}$    | Logic "0" input voltage                                |                               |     |     | 0.8 |         |
| $V_{OH}$    | High level output voltage, $V_{BIAS} - V_O$            | $I_O = 0A$                    |     |     | 1.4 |         |
| $V_{OL}$    | Low level output voltage, $V_O$                        | $I_O = 20mA$                  |     |     | 0.2 |         |
| $I_{LK}$    | Offset supply leakage current                          | $V_B = V_S = 600V$            |     |     | 50  | $\mu A$ |
| $I_{BSQ}$   | Quiescent $V_{BS}$ supply current                      | $V_{IN} = 0V$ or $5V$         | 20  | 60  | 150 |         |
| $I_{CCQ}$   | Quiescent $V_{CC}$ supply current                      | $V_{IN} = 0V$ or $5V$         | 50  | 120 | 240 | $\mu A$ |
| $I_{IN+}$   | Logic "1" input bias current                           | $V_{IN} = 5V$                 |     | 25  | 60  | $\mu A$ |
| $I_{IN-}$   | Logic "0" input bias current                           | $V_{IN} = 0V$                 |     |     | 5.0 |         |
| $V_{BSUV+}$ | $V_{BS}$ supply under-voltage positive going threshold |                               | 8.0 | 8.9 | 9.8 | V       |
| $V_{BSUV-}$ | $V_{BS}$ supply under-voltage negative going threshold |                               | 7.4 | 8.2 | 9.0 |         |
| $V_{CCUV+}$ | $V_{CC}$ supply under-voltage positive going threshold |                               | 8.0 | 8.9 | 9.8 |         |
| $V_{CCUV-}$ | $V_{CC}$ supply under-voltage negative going threshold |                               | 7.4 | 8.2 | 9.0 |         |
| $I_{O+}$    | Output high short circuit pulsed current               | $V_O = 0V, PW \leq 10 \mu s$  | 1.4 | 1.9 |     | A       |
| $I_{O-}$    | Output low short circuit pulsed current                | $V_O = 15V, PW \leq 10 \mu s$ | 1.7 | 2.3 |     |         |

**NOTE4** The  $V_{IN}$ ,  $V_{TH}$ , and  $I_{IN}$  parameters are applicable to the two logic input pins: LIN and HIN. The  $V_O$  and  $I_O$  parameters are applicable to the respective output pins: HO and LO.

**NOTES** For optimal operation, it is highly recommended that the input pulse (to HIN and LIN) should have an amplitude of 2.5V minimum with a pulse width of 360ns minimum.



## AC Electrical Characteristics

$V_{BIAS} (V_{CC}, V_{BS}) = 15V$ ,  $C_L = 1000pF$ , and  $T_A = 25\text{ }^\circ\text{C}$ , unless otherwise specified.

| Symbol    | Parameter                           | Conditions           | MIN | TYP | MAX | Unit |
|-----------|-------------------------------------|----------------------|-----|-----|-----|------|
| $t_{on}$  | Turn-on propagation delay           | $V_S = 0V$           |     | 180 | 270 | ns   |
| $t_{off}$ | Turn-off propagation delay          | $V_S = 0V$ or $600V$ |     | 220 | 330 |      |
| $t_{DM}$  | Delay matching, HS & LS turn-on/off |                      |     |     | 35  |      |
| $t_r$     | Turn-on rise time                   | $V_S = 0V$           |     | 40  | 60  |      |
| $t_f$     | Turn-off fall time                  |                      |     | 20  | 35  |      |



Timing Waveforms

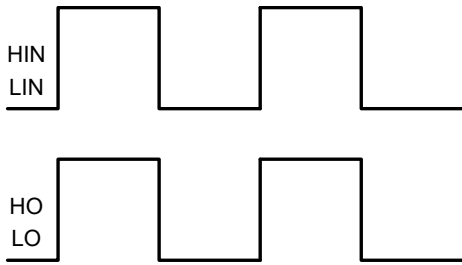


Figure 1. Input / Output Timing Diagram

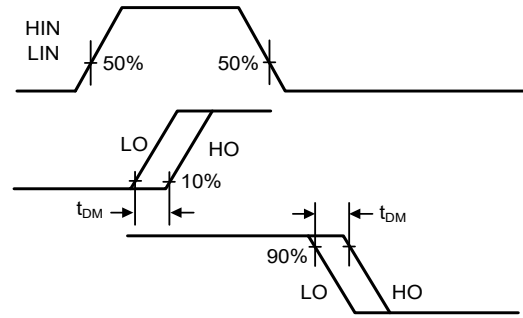


Figure 2. Delay Matching Waveform Definitions

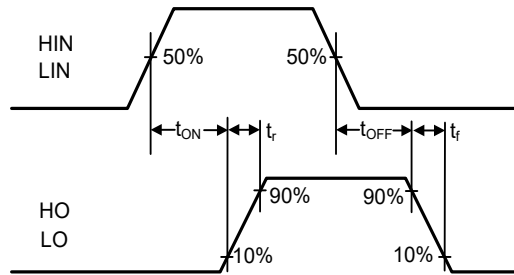
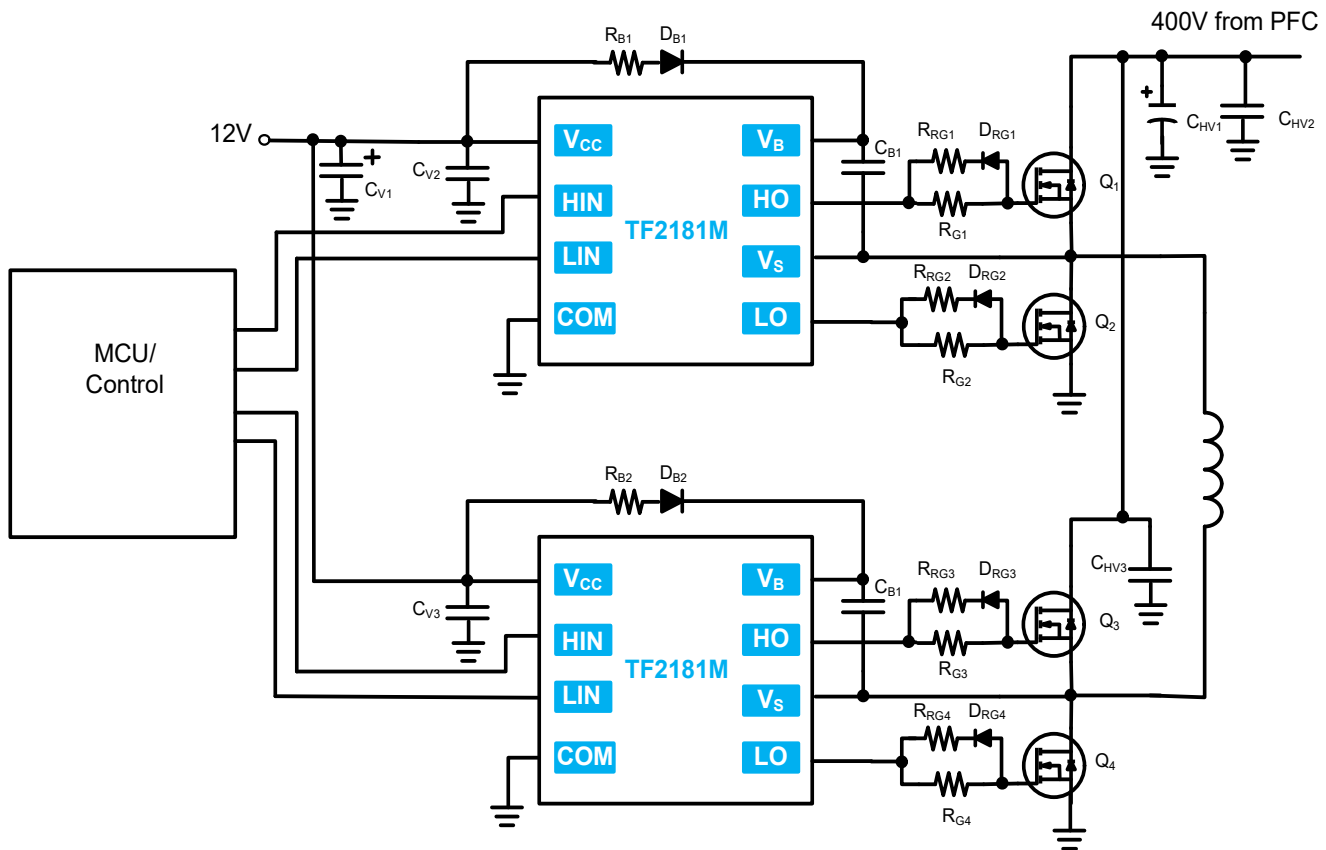


Figure 3. Switching Time Waveform Definitions

## Application Information



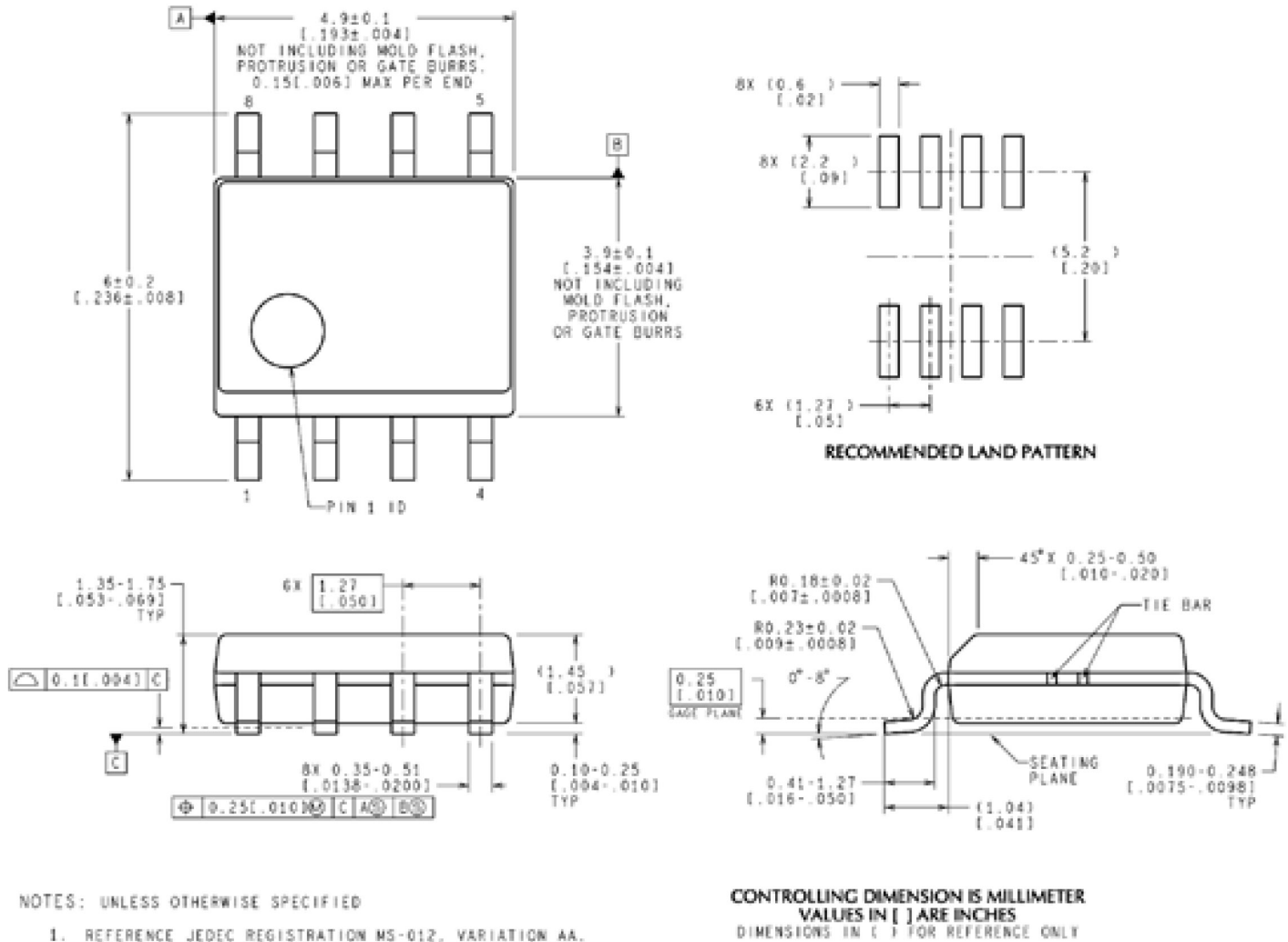
**Figure 4.** Primary side of Full Bridge converter using TF2181M

- RRG1, RRG2, RRG3, and RRG4 values are typically between  $0\Omega$  and  $10\Omega$ , exact value decided by MOSFET junction capacitance and drive current of gate driver;  $10\Omega$  is used in this example.
- It is **highly recommended** that the input pulse (to HIN and LIN) should have an amplitude of 2.5V minimum (for VDD=15V) with a minimum pulse width of 360ns.
- RG1, RG2, RG3, and RG4 values are typically between  $20\Omega$  and  $100\Omega$ , exact value decided by MOSFET junction capacitance and drive current of gate driver;  $50\Omega$  is used in this example.
- RB1 and RB2 value is typically between  $3\Omega$  and  $20\Omega$ , exact value depending on bootstrap capacitor value and amount of current limiting required for bootstrap capacitor charging;  $10\Omega$  is used in this example. Also DB1 and DB2 should be an ultra fast diode of 1A rating minimum and voltage rating greater than system operating voltage.



## Package Dimensions (SOIC-8 N)

Please contact [support@tfsemi.com](mailto:support@tfsemi.com) for package availability.







## Revision History

| Rev. | Change                         | Owner           | Date       |
|------|--------------------------------|-----------------|------------|
| 1.0  | First release, final datasheet | Keith Spaulding | 8/5/2020   |
| 1.1  | Changed IO- min.               | Keith Spaulding | 10/15/2020 |
| 1.2  | Application notes update       | Raj Selvaraj    | 06/22/2021 |

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